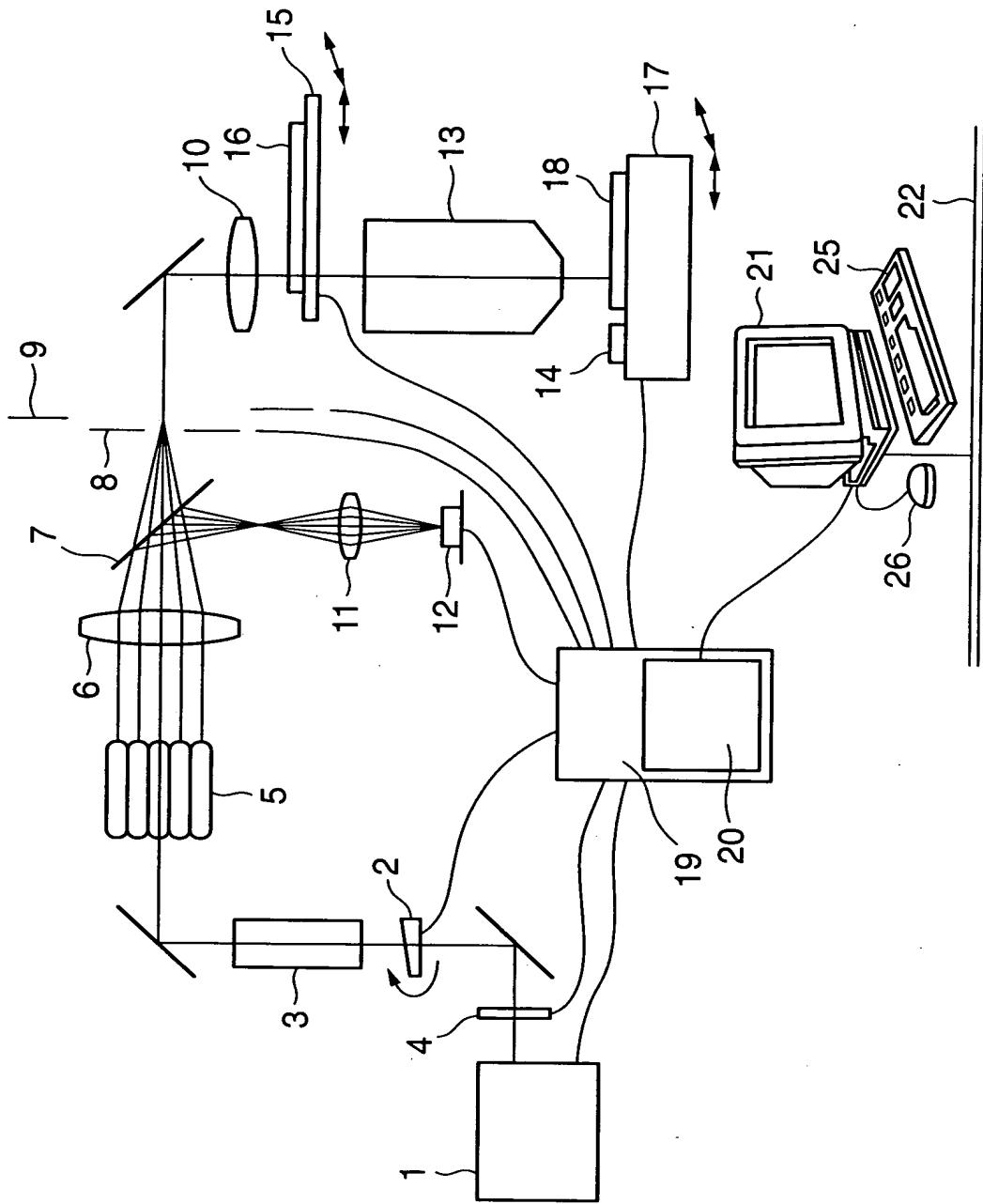
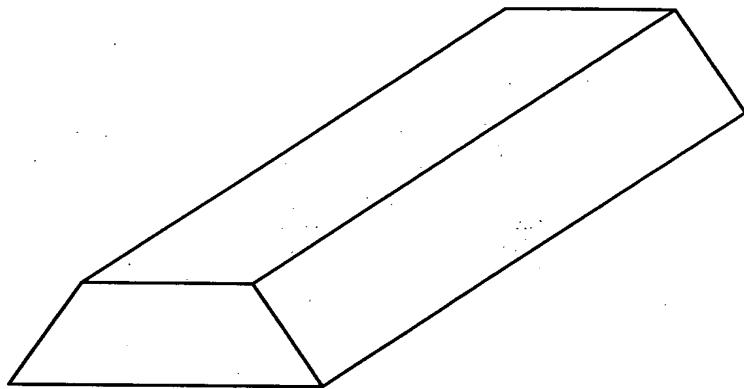


FIG. 1



2/15

FIG. 2



### SCANNING EXPOSURE DIRECTION



1002260 3434500

FIG. 3

3/15

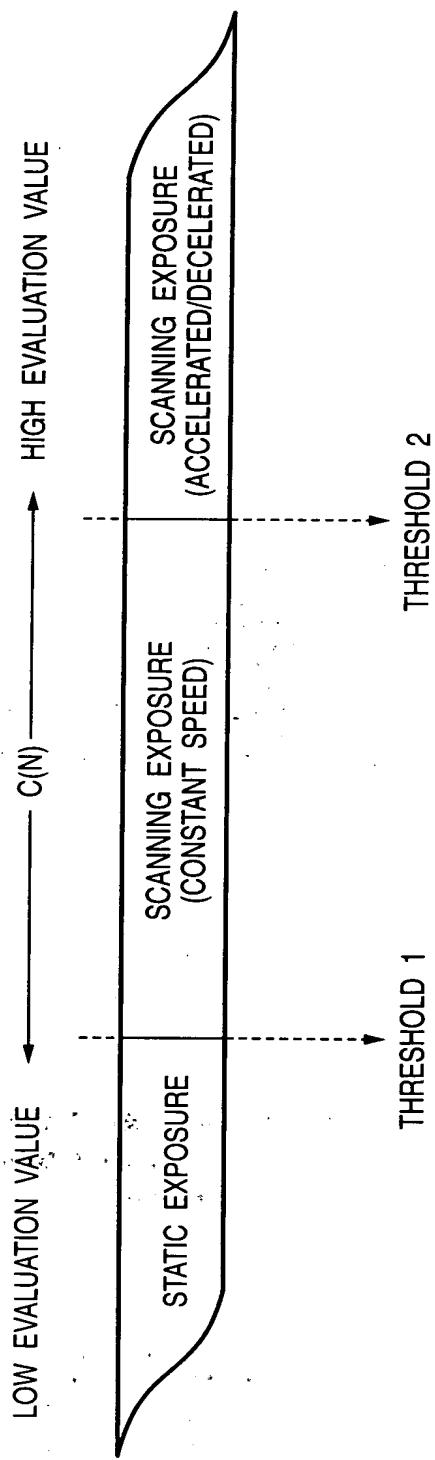


FIG. 4

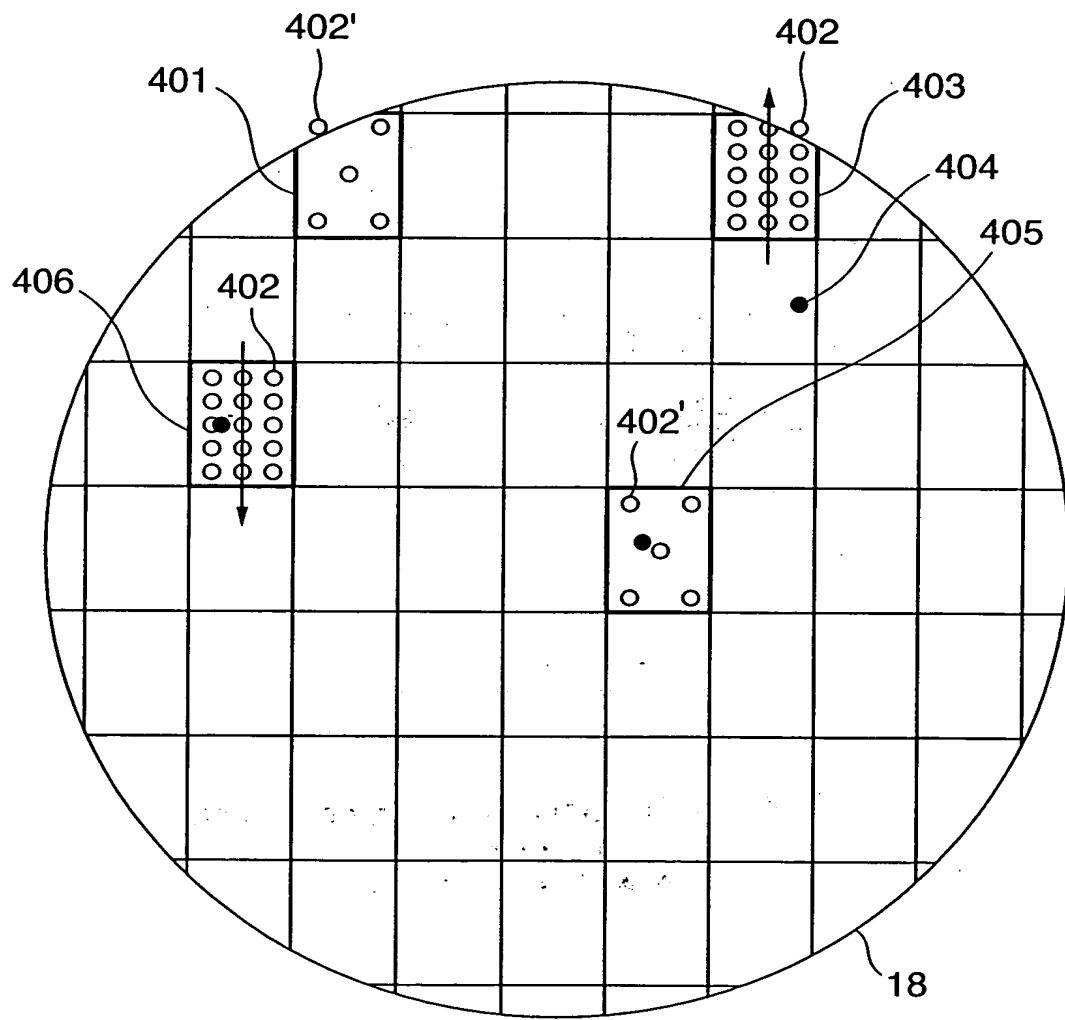
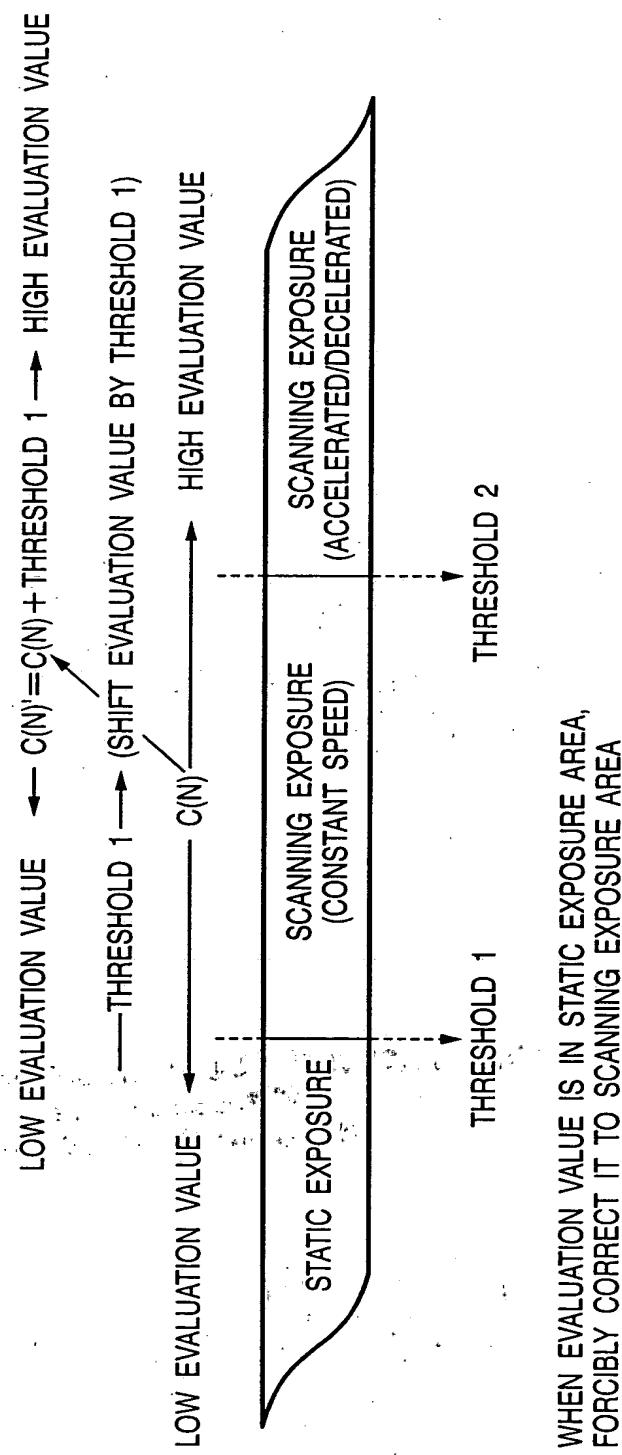


FIG. 5A



WHEN EVALUATION VALUE IS IN STATIC EXPOSURE AREA,  
FORCIBLY CORRECT IT TO SCANNING EXPOSURE AREA

FIG. 5B

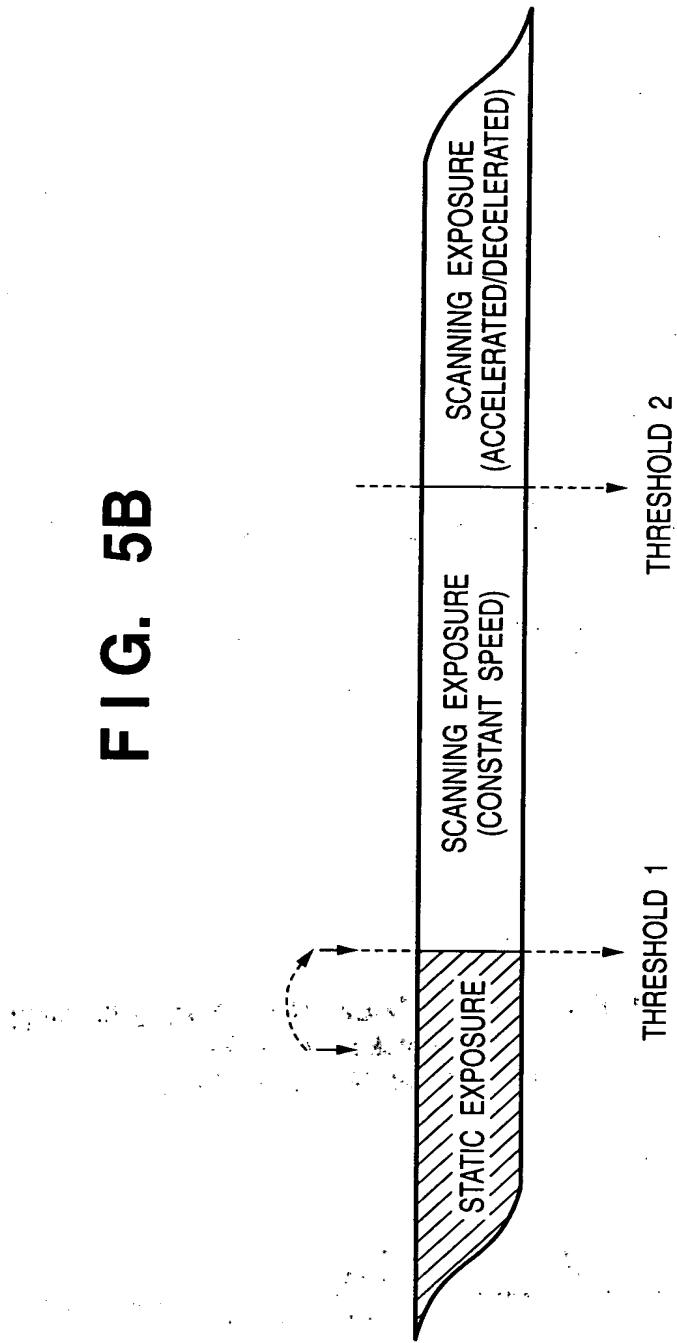


FIG. 6

00000000000000000000000000000000

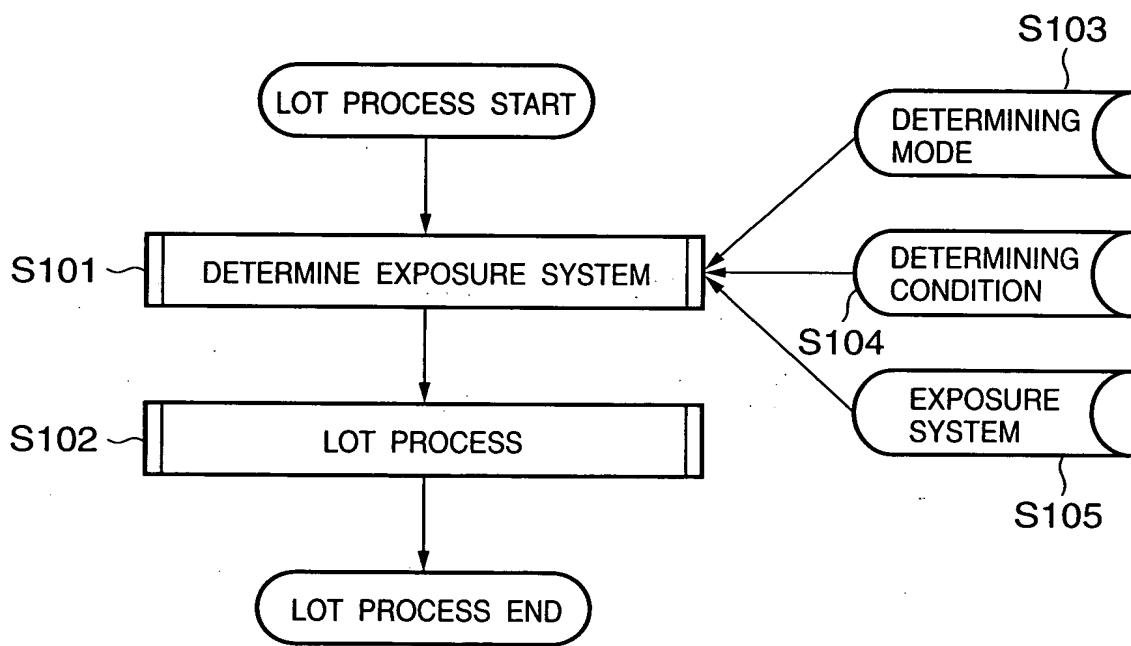
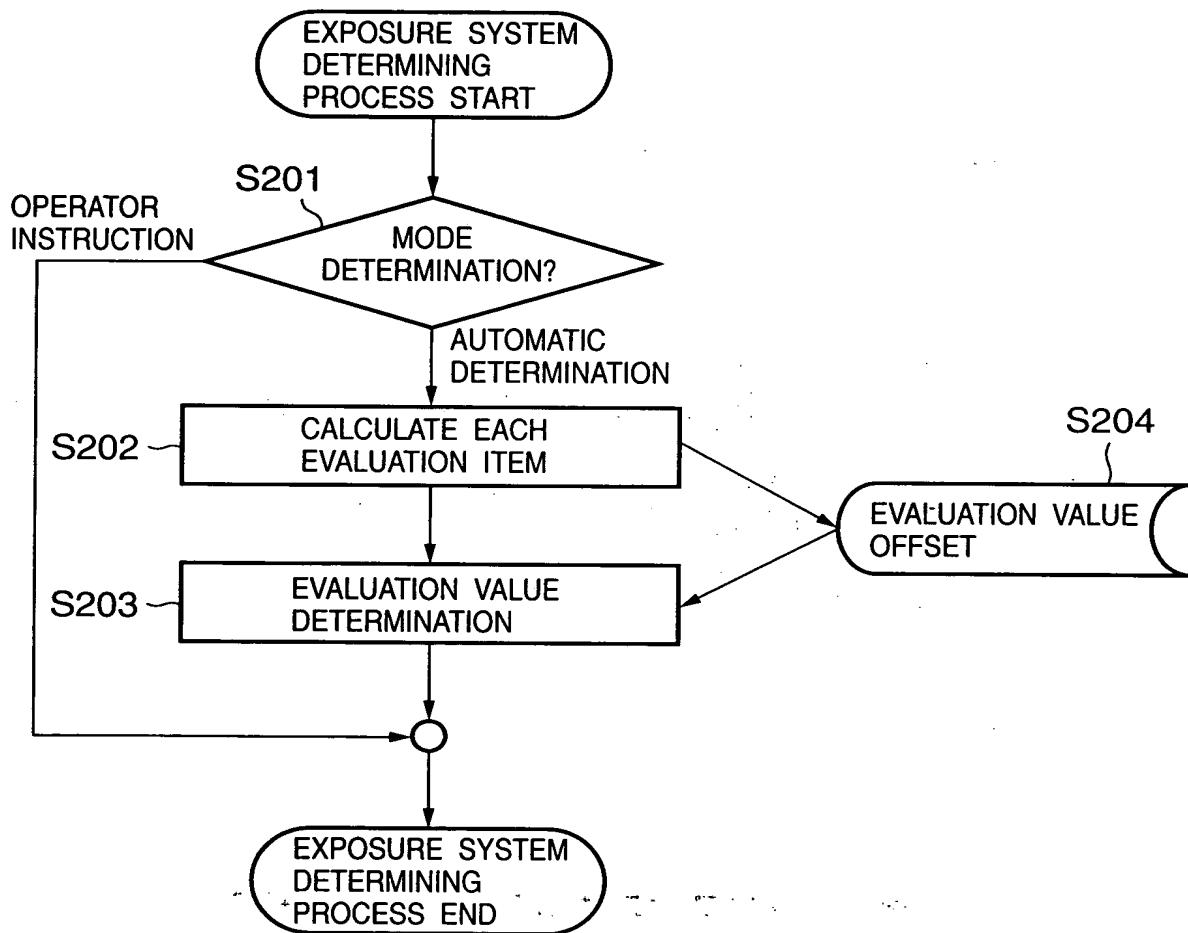


FIG. 7



09034464-00-292901

FIG. 8A

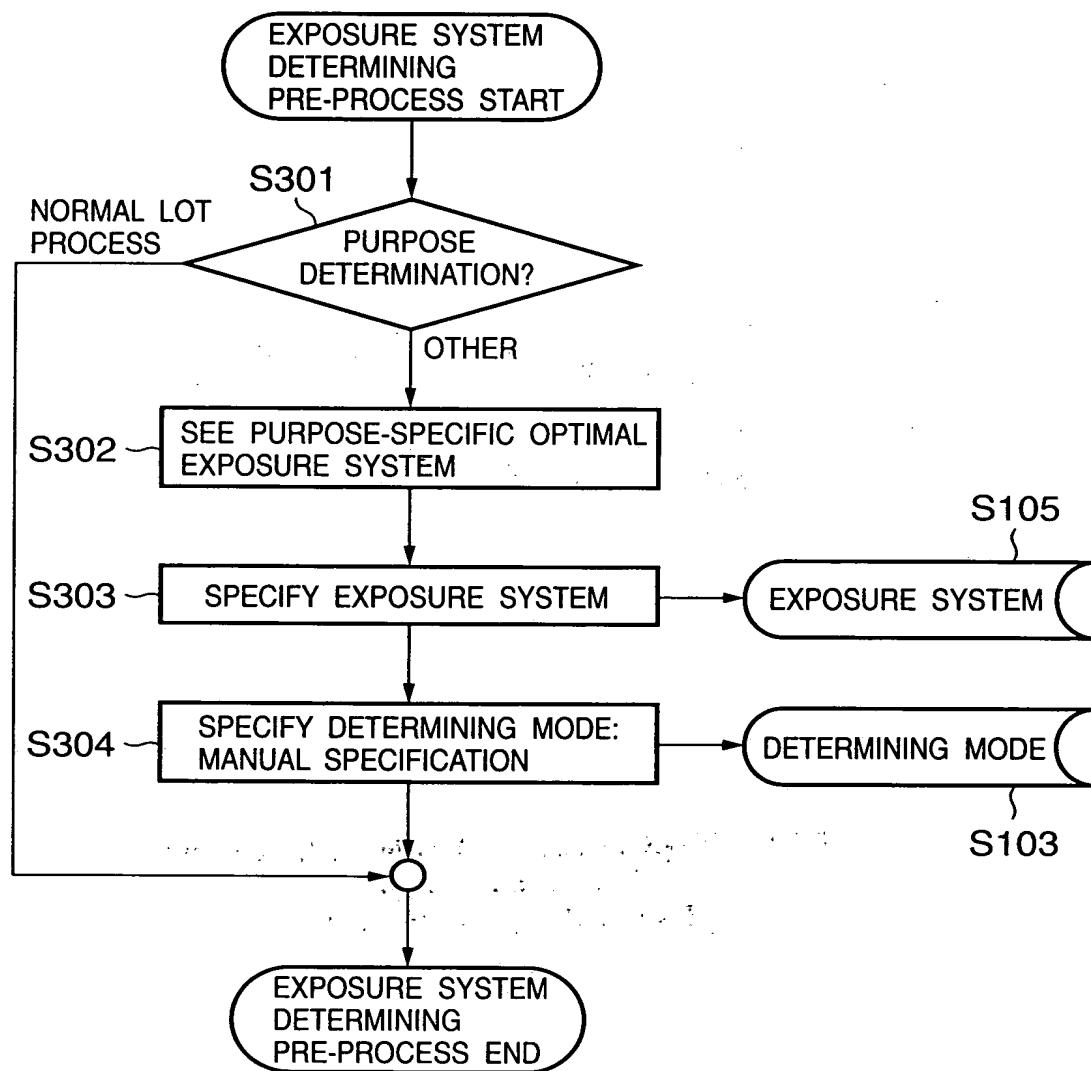


FIG. 8B

TOP SECRET//COMINT

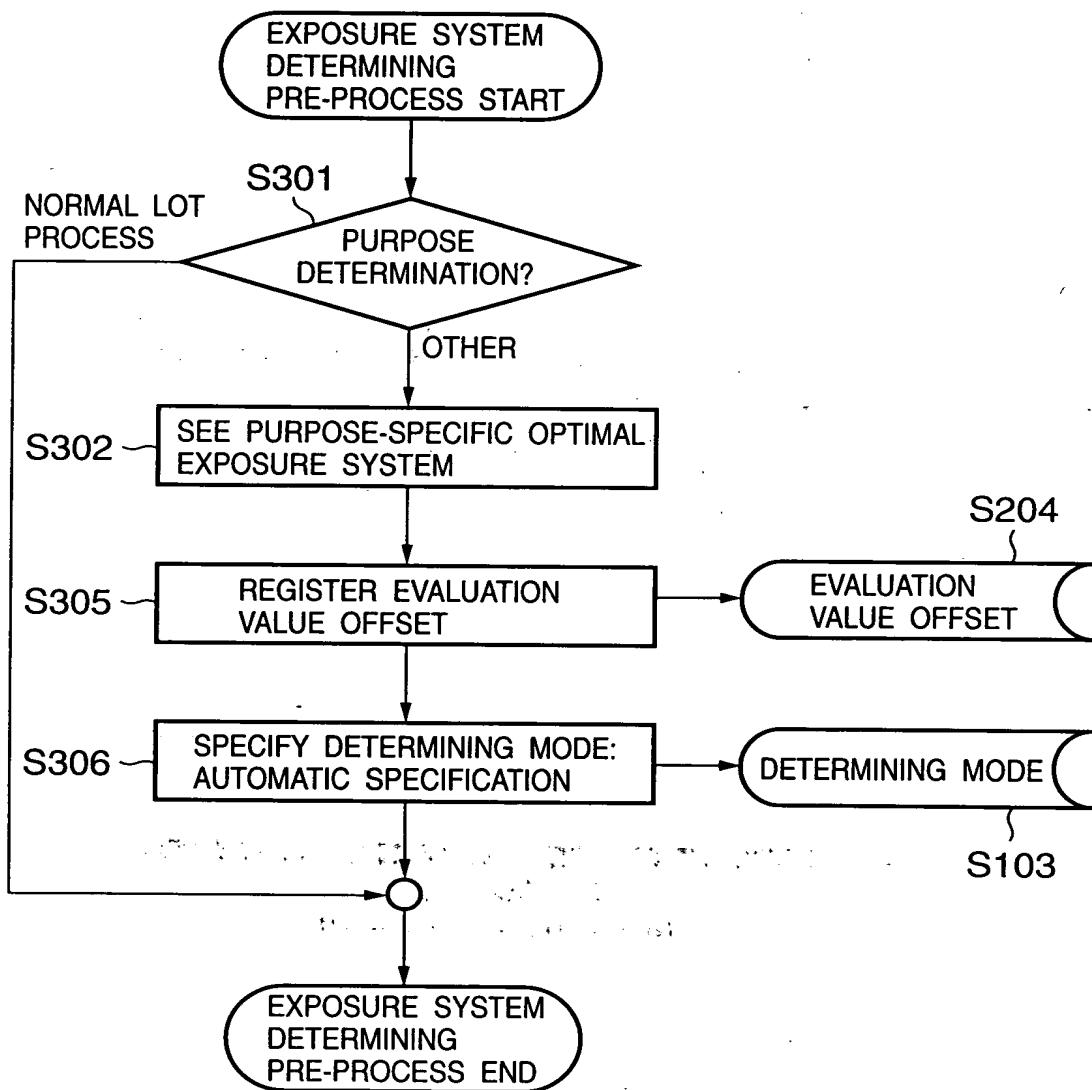


FIG. 9

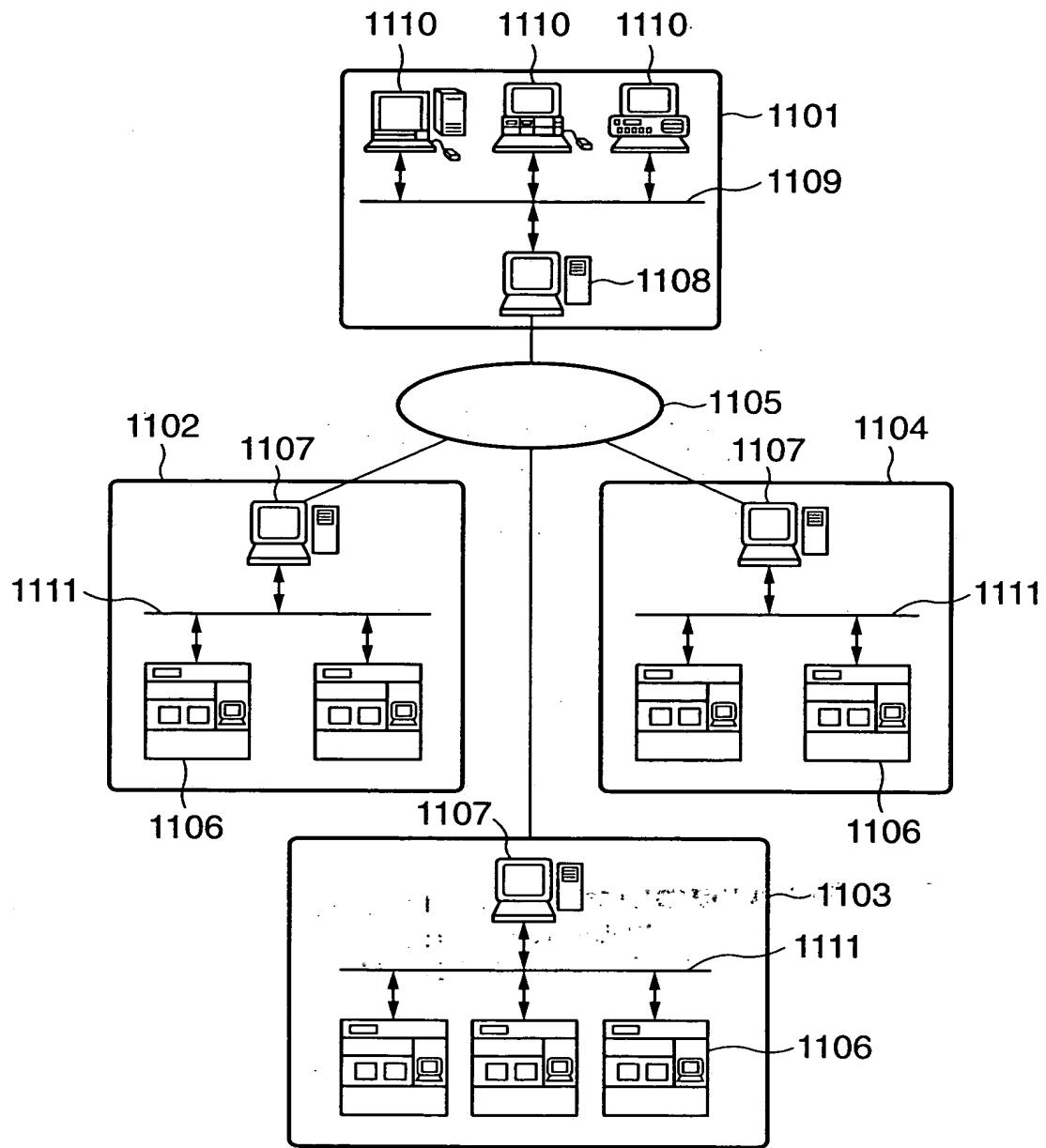
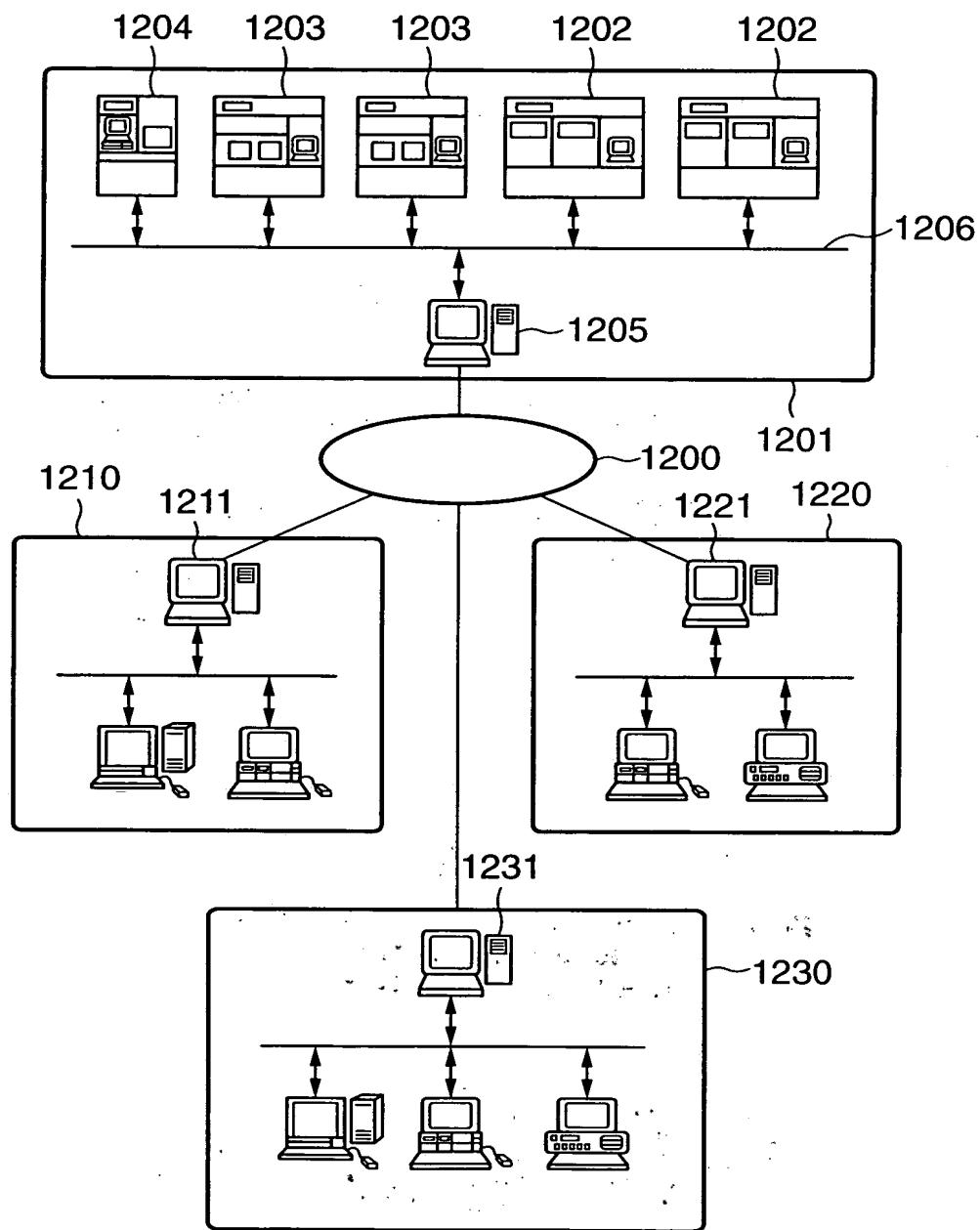


FIG. 10



## FIG. 11

URL <http://www.maintain.co.jp/db/input.html>

TROUBLE DB INPUT SCREEN

DATE OF OCCURRENCE  ~ 1404

MODEL  ~ 1401

CASE NAME  ~ 1403

DEVICE  ~ 1402

EMERGENCY LEVEL  ~ 1405

SYMPTOM  ~ 1406

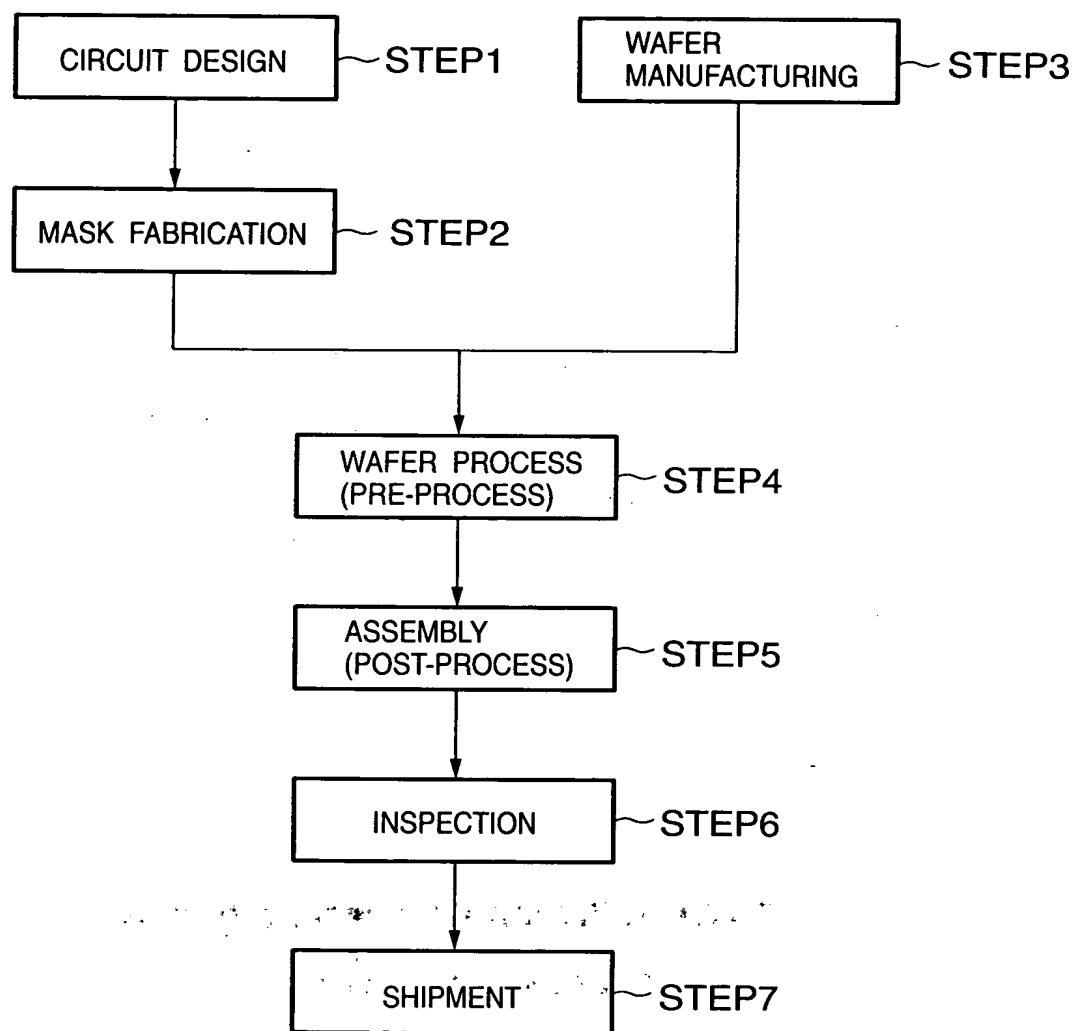
REMEDY  ~ 1407

PROGRESS  ~ 1408

1410 1411 1412

LINK TO RESULT LIST DATABASE SOFTWARE LIBRARY OPERATION GUIDE

FIG. 12



SEMICONDUCTOR DEVICE MANUFACTURING FLOW

FIG. 13

